

## P-Channel 30 V (D-S) MOSFET

|                  |               |     |            |
|------------------|---------------|-----|------------|
| $V_{DS}$         |               | -30 | V          |
| $R_{DS(on),typ}$ | $V_{GS}=10V$  | 11  | m $\Omega$ |
| $R_{DS(on),typ}$ | $V_{GS}=4.5V$ | 18  | m $\Omega$ |
| $I_D$            |               | -45 | A          |

### FEATURES

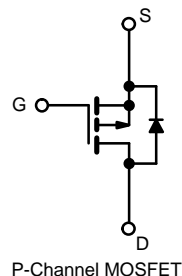
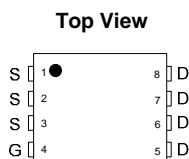
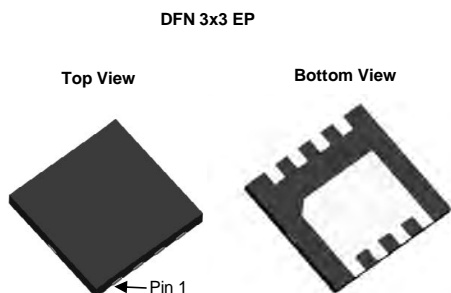
- Halogen-free According to IEC 61249-2-21 Definition
- Trench Power MOSFET
- Low Thermal Resistance  
Package with Small Size and Low 1.07 mm Profile
- 100 %  $R_g$  and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



**RoHS**  
COMPLIANT  
HALOGEN  
**FREE**

### APPLICATIONS

- Load Switch
- Adaptor Switch
- Notebook PC



P-Channel MOSFET

### ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^{\circ}\text{C}$ , unless otherwise noted)

| Parameter  | Symbol         | Limit                              | Unit                   |
|--|----------------|------------------------------------|------------------------|
| Drain-Source Voltage   | $V_{DS}$       | - 30                               | V                      |
| Gate-Source Voltage  | $V_{GS}$       | $\pm 20$                           | V                      |
| Continuous Drain Current ( $T_J = 150\text{ }^{\circ}\text{C}$ ) | $I_D$          | $T_C = 25\text{ }^{\circ}\text{C}$ | - 45                   |
|  |                | $T_C = 70\text{ }^{\circ}\text{C}$ | - 30                   |
|  |                | $T_A = 25\text{ }^{\circ}\text{C}$ | - 14.4 <sup>a, b</sup> |
|  |                | $T_A = 70\text{ }^{\circ}\text{C}$ | - 11.5 <sup>a, b</sup> |
| Pulsed Drain Current   | $I_{DM}$       | - 60                               | A                      |
| Continuous Source-Drain Diode Current                            | $I_S$          | $T_C = 25\text{ }^{\circ}\text{C}$ | - 35 <sup>e</sup>      |
|  |                | $T_A = 25\text{ }^{\circ}\text{C}$ | - 3.2 <sup>a, b</sup>  |
| Avalanche Current  | $I_{AS}$       | - 25                               | A                      |
| Single-Pulse Avalanche Energy                                    | $E_{AS}$       | 31.25                              | mJ                     |
| Maximum Power Dissipation  | $P_D$          | $T_C = 25\text{ }^{\circ}\text{C}$ | 52                     |
|  |                | $T_C = 70\text{ }^{\circ}\text{C}$ | 43                     |
|  |                | $T_A = 25\text{ }^{\circ}\text{C}$ | 3.8 <sup>a, b</sup>    |
|  |                | $T_A = 70\text{ }^{\circ}\text{C}$ | 2.4 <sup>a, b</sup>    |
| Operating Junction and Storage Temperature Range                 | $T_J, T_{stg}$ | - 50 to 150                        | $^{\circ}\text{C}$     |
| Soldering Recommendations (Peak Temperature) <sup>c, d</sup>     |                | 260                                |                        |

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b.  $t = 10\text{ s}$ .

c. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.

d. Package limited.

e. Based on  $T_C = 25\text{ }^{\circ}\text{C}$

**THERMAL RESISTANCE RATINGS**

| Parameter                                   |               | Symbol     | Typical | Maximum | Unit |
|---|---------------|------------|---------|---------|------|
| Maximum Junction-to-Ambient <sup>a, b</sup> | $t \leq 10$ s | $R_{thJA}$ | 26      | 33      | °C/W |
| Maximum Junction-to-Case (Drain)            | Steady State  | $R_{thJC}$ | 1.9     | 2.4     |      |

Notes:

a. Surface mounted on 1" x 1" FR4 board.

b. Maximum under Steady State conditions is 81 °C/W.

**SPECIFICATIONS** ( $T_J = 25$  °C, unless otherwise noted)

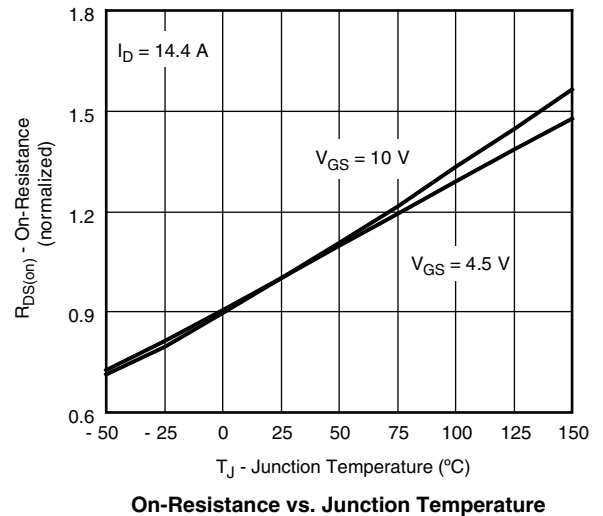
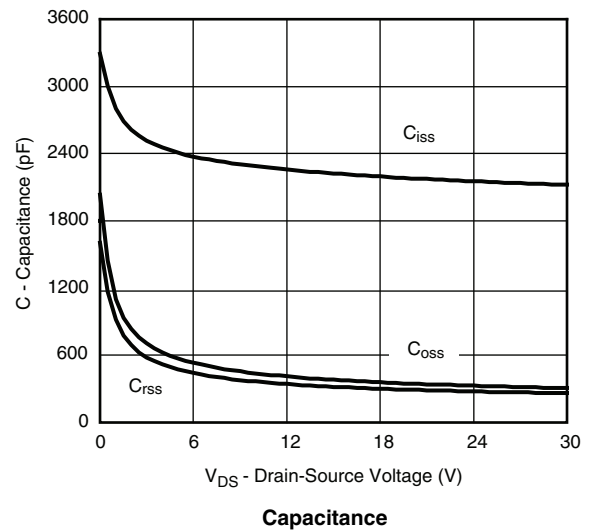
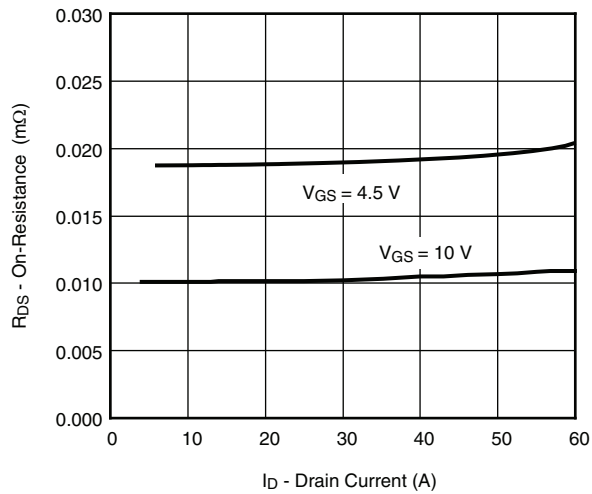
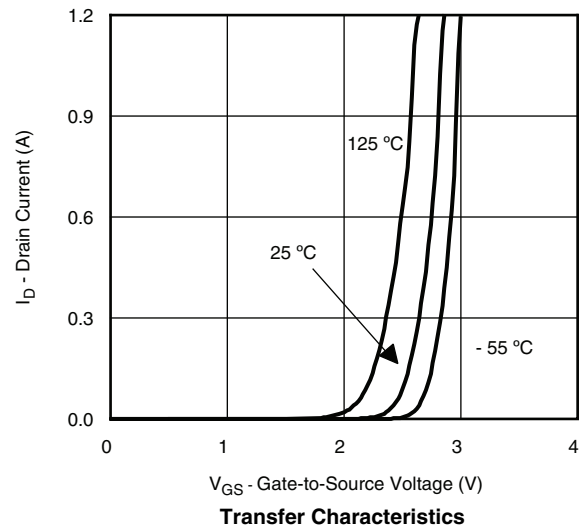
| Parameter                                     | Symbol                               | Test Conditions   | Min.  | Typ.  | Max.              | Unit  |
|---|--------------------------------------|---|-------|-------|-------------------|-------|
| Static  |                                      |   |       |       |                   |       |
| Drain-Source Breakdown Voltage                | V <sub>DS</sub>                      | V <sub>GS</sub> = 0 V, I <sub>D</sub> = - 250 μA  | - 30  |       |                   | V     |
| V <sub>DS</sub> Temperature Coefficient       | ΔV <sub>DS</sub> /T <sub>J</sub>     | I <sub>D</sub> = - 250 μA   |       | - 20  |                   | mV/°C |
| V <sub>GS(th)</sub> Temperature Coefficient   | ΔV <sub>GS(th)</sub> /T <sub>J</sub> |   |       | 5     |                   |       |
| Gate-Source Threshold Voltage                 | V <sub>GS(th)</sub>                  | V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = - 250 μA   | - 1.5 |       | - 2.8             | V     |
| Gate-Source Leakage                           | I <sub>GSS</sub>                     | V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 20 V   |       |       | ± 100             | nA    |
| Zero Gate Voltage Drain Current               | I <sub>DSS</sub>                     | V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V   |       |       | - 1               | μA    |
|   |                                      | V <sub>DS</sub> = - 30 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C   |       |       | - 10              |       |
| On-State Drain Current <sup>a</sup>           | I <sub>D(on)</sub>                   | V <sub>DS</sub> ≤ - 5 V, V <sub>GS</sub> = - 10 V   | - 20  |       |                   | A     |
| Drain-Source On-State Resistance <sup>a</sup> | R <sub>DS(on)</sub>                  | V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14.4 A   |       | 11    |                   | mΩ    |
|   |                                      | V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 11.5 A  |       | 18    |                   |       |
| Forward Transconductance <sup>a</sup>         | g <sub>fs</sub>                      | V <sub>DS</sub> = - 15 V, I <sub>D</sub> = - 14.4 A   |       | 37    |                   | S     |
| Dynamic <sup>b</sup>                          |                                      |   |       |       |                   |       |
| Input Capacitance                             | C <sub>iss</sub>                     | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = 0 V, f = 1 MHz  |       | 2000  |                   | pF    |
| Output Capacitance                            | C <sub>oss</sub>                     |   |       | 385   |                   |       |
| Reverse Transfer Capacitance                  | C <sub>rss</sub>                     |   |       | 322   |                   |       |
| Total Gate Charge                             | Q <sub>g</sub>                       | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 10 V, I <sub>D</sub> = - 14.4 A   |       |       | 15                | nC    |
|   |                                      | V <sub>DS</sub> = - 15 V, V <sub>GS</sub> = - 4.5 V, I <sub>D</sub> = - 14.4 A  |       |       | 14                |       |
| Gate-Source Charge                            | Q <sub>gs</sub>                      |   |       |       | 7                 |       |
| Gate-Drain Charge                             | Q <sub>gd</sub>                      |   |       |       | 9                 |       |
| Gate Resistance                               | R <sub>g</sub>                       | f = 1 MHz   | 0.4   | 1.8   | 3.6               | Ω     |
| Turn-On Delay Time                            | t <sub>d(on)</sub>                   | V <sub>DD</sub> = - 15 V, R <sub>L</sub> = 1.5 Ω<br>I <sub>D</sub> ≡ - 10 A, V <sub>GEN</sub> = - 4.5 V, R <sub>g</sub> = 1 Ω |       | 50    | 75                | ns    |
| Rise Time                                     | t <sub>r</sub>                       |   |       | 43    | 65                |       |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>                  |   |       | 30    | 45                |       |
| Fall Time                                     | t <sub>f</sub>                       |   |       | 14    | 21                |       |
| Turn-On Delay Time                            | t <sub>d(on)</sub>                   | V <sub>DD</sub> = - 15 V, R <sub>L</sub> = 1.5 Ω<br>I <sub>D</sub> ≡ - 10 A, V <sub>GEN</sub> = - 10 V, R <sub>g</sub> = 1 Ω  |       | 14    | 21                |       |
| Rise Time                                     | t <sub>r</sub>                       |   |       | 9     | 18                |       |
| Turn-Off DelayTime                            | t <sub>d(off)</sub>                  |   |       | 36    | 54                |       |
| Fall Time                                     | t <sub>f</sub>                       |   |       | 10    | 20                |       |
| Drain-Source Body Diode Characteristics       |                                      |   |       |       |                   |       |
| Continuous Source-Drain Diode Current         | I <sub>S</sub>                       | T <sub>C</sub> = 25 °C  |       |       | - 35 <sup>e</sup> | A     |
| Pulse Diode Forward Current <sup>a</sup>      | I <sub>SM</sub>                      |   |       |       | - 60              |       |
| Body Diode Voltage                            | V <sub>SD</sub>                      | I <sub>F</sub> = - 10 A   |       | - 0.8 | - 1.2             | V     |
| Body Diode Reverse Recovery Time              | t <sub>rr</sub>                      | I <sub>F</sub> = - 10 A, dI/dt = 100 A/μs, T <sub>J</sub> = 25 °C   |       | 31    | 47                | ns    |
| Body Diode Reverse Recovery Charge            | Q <sub>rr</sub>                      |   |       | 30    | 45                | nC    |
| Reverse Recovery Fall Time                    | t <sub>a</sub>                       |   |       | 15    |                   | ns    |
| Reverse Recovery Rise Time                    | t <sub>b</sub>                       |   |       | 16    |                   |       |

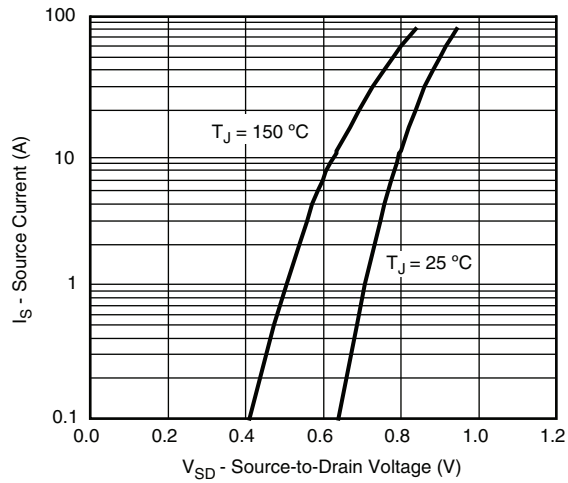
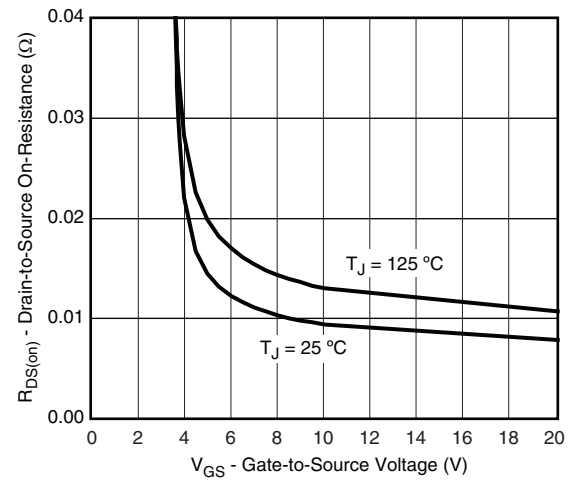
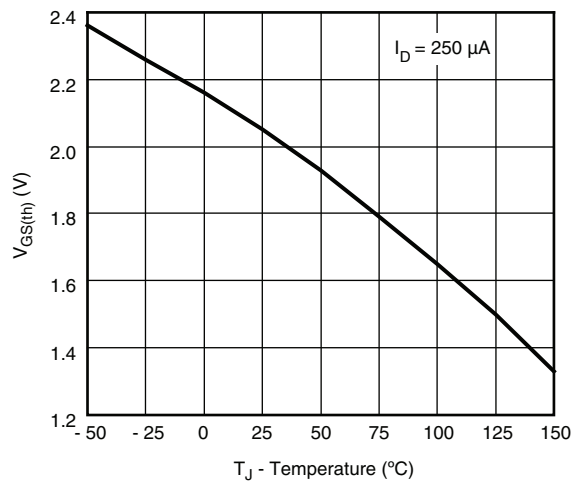
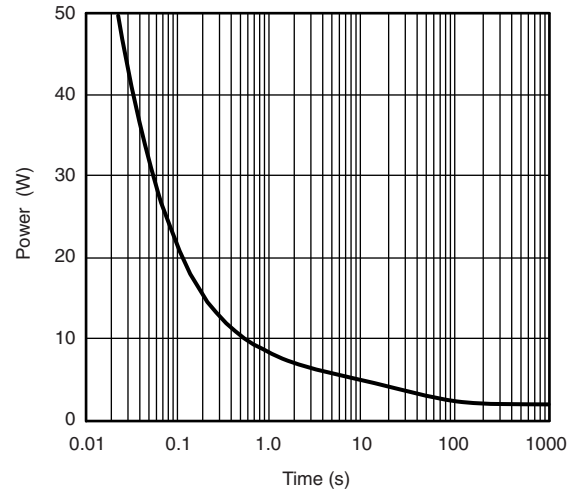
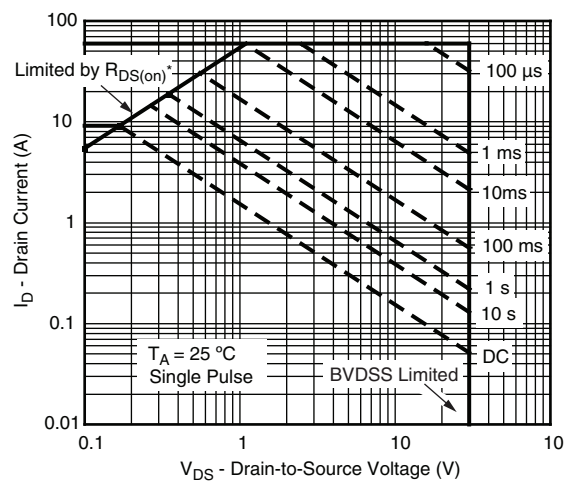
Notes:

a. Pulse test; pulse width  $\leq 300$   $\mu$ s, duty cycle  $\leq 2$  %.

b. Guaranteed by design, not subject to production testing.

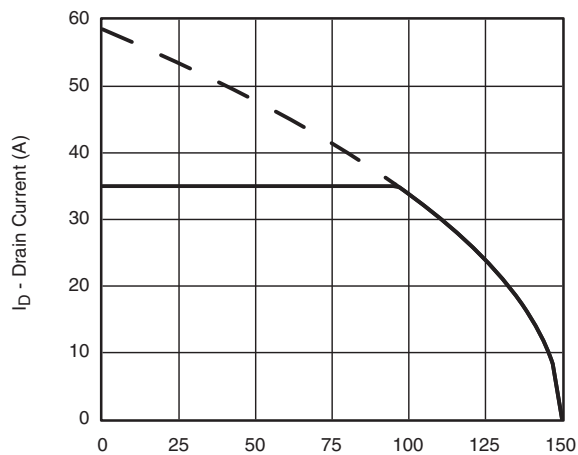
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

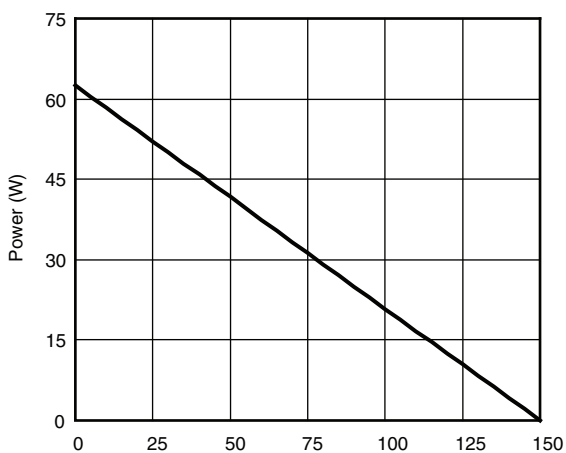
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)


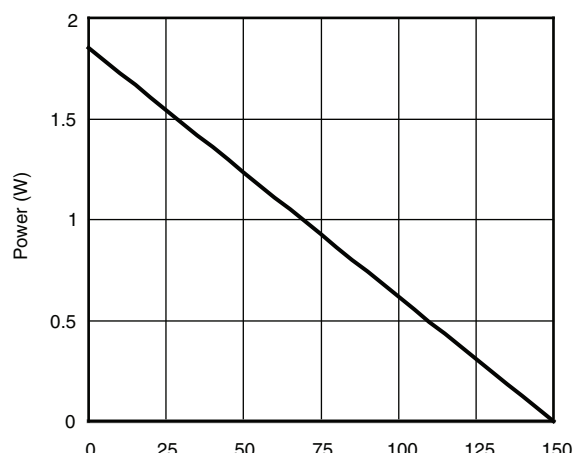
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

**Source-Drain Diode Forward Voltage**

**On-Resistance vs. Gate-to-Source Voltage**

**Threshold Voltage**

**Single Pulse Power, Junction-to-Ambient**


\*  $V_{GS} >$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is Specified

**Safe Operating Area, Junction-to-Ambient**

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)

 $T_C$  - Case Temperature (°C)

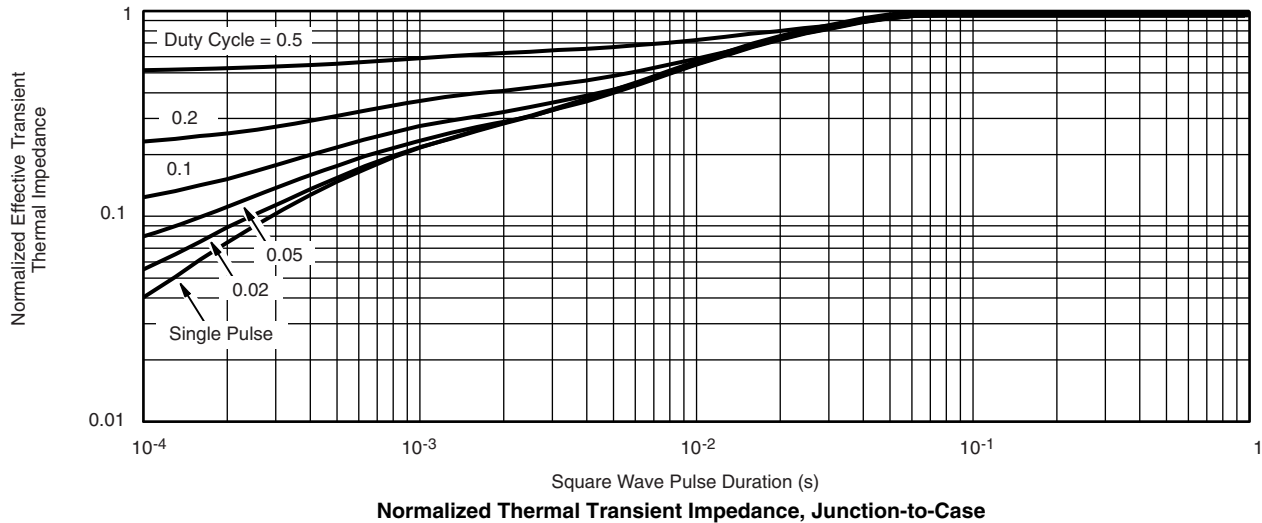
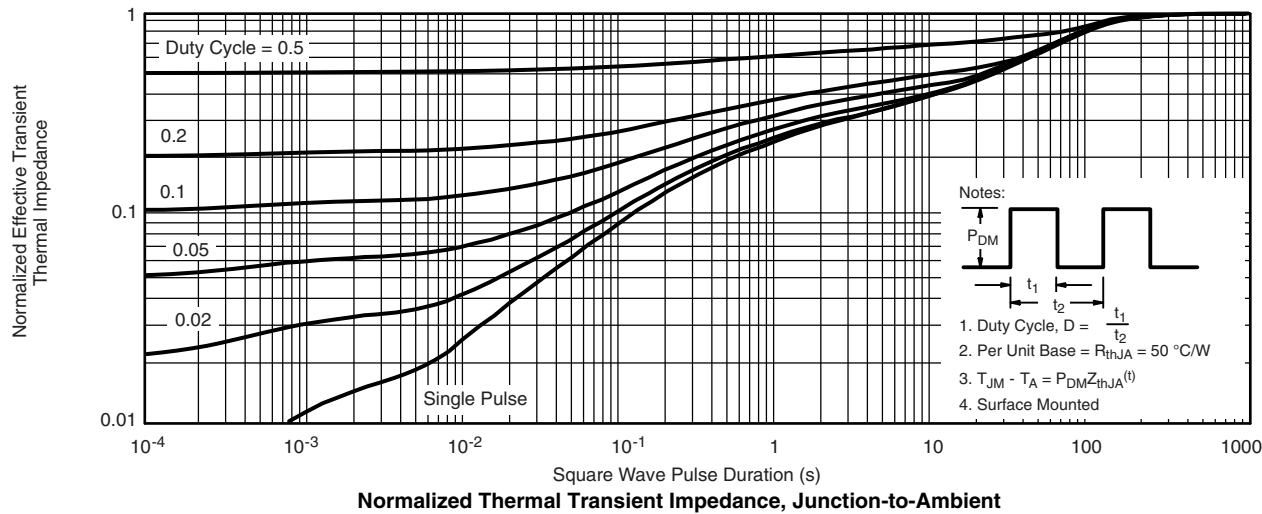
**Current Derating\***

 $T_C$  - Case Temperature (°C)

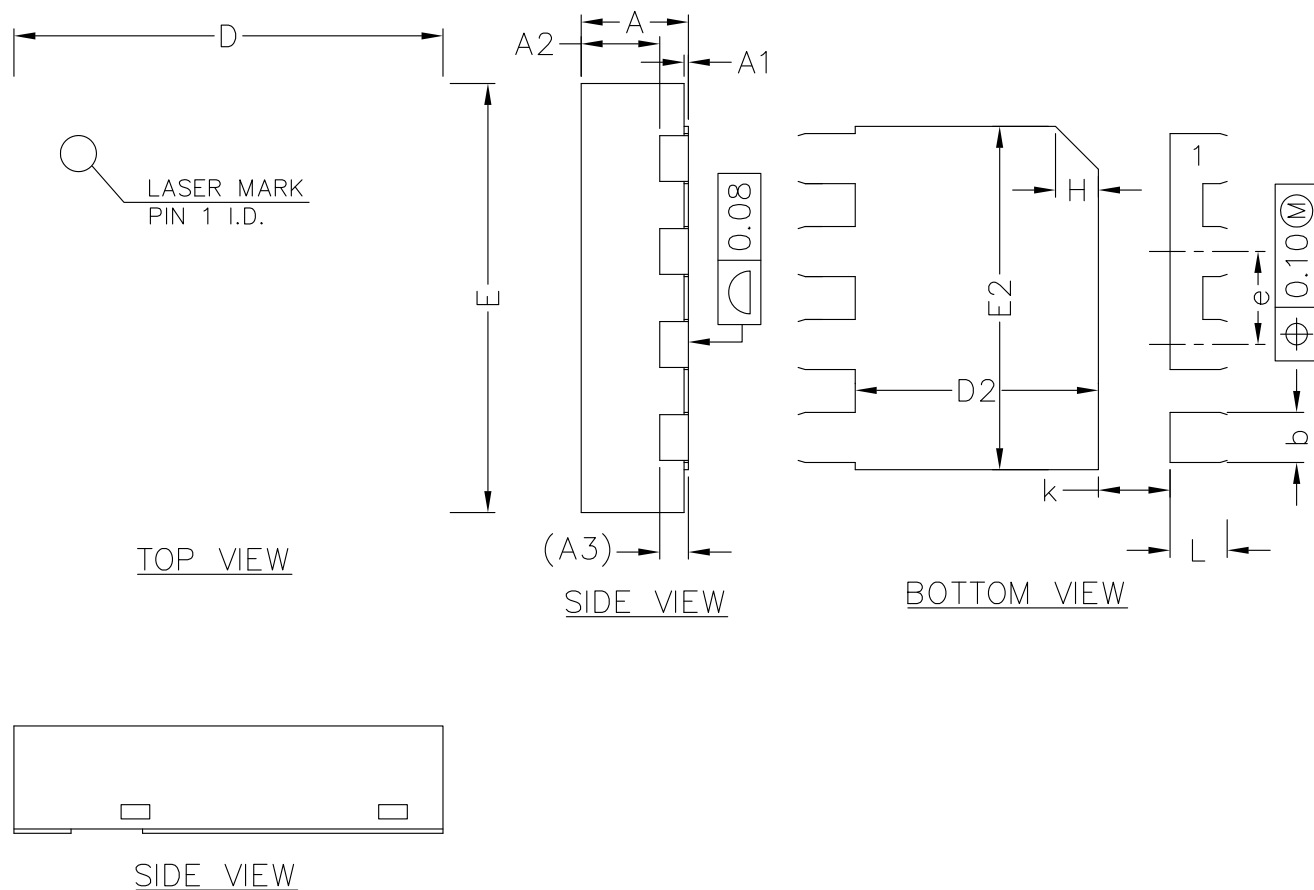
**Power, Junction-to-Case**

 $T_A$  - Ambient Temperature (°C)

**Power, Junction-to-Ambient**

\* The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)





COMMON DIMENSIONS  
(UNITS OF MEASURE=MILLIMETER)

| SYMBOL | MIN     | NOM  | MAX  |
|--------|---------|------|------|
| A      | 0.70    | 0.75 | 0.80 |
| A1     | 0.00    | 0.02 | 0.05 |
| A2     | 0.50    | 0.55 | 0.60 |
| A3     | 0.20REF |      |      |
| b      | 0.30    | 0.35 | 0.40 |
| D      | 2.90    | 3.00 | 3.10 |
| E      | 2.90    | 3.00 | 3.10 |
| D2     | 1.60    | 1.70 | 1.80 |
| E2     | 2.30    | 2.40 | 2.50 |
| e      | 0.55    | 0.65 | 0.75 |
| K      | 0.40    | 0.50 | 0.60 |
| L      | 0.35    | 0.40 | 0.45 |

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